

Notice of References Cited	Application/Control No. 10/625,836	Applicant(s)/Patent Under Reexamination DEATON ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,515,486 A	05-1996	Amro et al.	715/848
*	B	US-5,671,381 A	09-1997	Strasnick et al.	715/848
*	C	US-5,670,984 A	09-1997	Robertson et al.	345/585
*	D	US-6,043,818 A	03-2000	Nakano et al.	715/851
*	E	US-6,281,898 B1	08-2001	Nikolovska et al.	715/848
*	F	US-6,304,259 B1	10-2001	DeStefano, George Francis	715/805
*	G	US-6,414,679 B1	07-2002	Miodonski et al.	345/420
*	H	US-6,496,842 B1	12-2002	Lyness, Stanley W.	715/514
*	I	US-2003/0120686 A1	06-2003	Kim et al.	707/200
*	J	US-2004/0090472 A1	05-2004	Risch et al.	345/853
*	K	US-2005/0021472 A1	01-2005	Gettman et al.	705/052
*	L	US-2005/0030309 A1	02-2005	Gettman et al.	345/419
*	M	US-7,002,573 B2	02-2006	Trotta et al.	345/420

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,678,015 A	10-1997	Goh, Eng Lim	715/782
*	B	US-6,222,547 B1	04-2001	Schwuttko et al.	345/419
*	C	US-6,301,579 B1	10-2001	Becker, Barry G.	707/102
*	D	US-6,331,858 B1	12-2001	Fisher, Kim J.	345/582
*	E	US-D458,611 S	06-2002	Gallo, Anthony Carmen	D14/485
*	F	US-2002/0133516 A1	09-2002	Davis et al.	707/513
*	G	US-6,466,239 B2	10-2002	Ishikawa, Masayuki	715/850
*	H	US-2002/0163546 A1	11-2002	Gallo, Anthony Carmen	345/848
*	I	US-6,505,194 B1	01-2003	Nikolovska et al.	707/3
*	J	US-6,731,314 B1	05-2004	Cheng et al.	715/848
*	K	US-2004/0140991 A1	07-2004	Trotta et al.	345/700
*	L	US-2005/0216515 A1	09-2005	Bray et al.	707/104.1
*	M	US-7,013,435 B2	03-2006	Gallo et al.	715/850

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,303,388 A	04-1994	Kreitman et al.	715/836
*	B	US-6,005,578 A	12-1999	Cole, W. Brooks	715/854
*	C	US-6,054,989 A	04-2000	Robertson et al.	715/848
*	D	US-6,166,738 A	12-2000	Robertson et al.	715/839
*	E	US-6,188,405 B1	02-2001	Czerwinski et al.	715/764
*	F	US-6,362,817 B1	03-2002	Powers et al.	345/419
*	G	US-2003/0046401 A1	03-2003	Abbott et al.	709/228
*	H	US-2003/0103064 A1	06-2003	Knighton et al.	345/660
*	I	US-6,628,313 B1	09-2003	Minakuchi et al.	715/853
*	J	US-6,636,246 B1	10-2003	Gallo et al.	715/805
*	K	US-6,938,218 B1	08-2005	Rosen, Mike	715/850
*	L	US-6,990,238 B1	01-2006	Saffer et al.	382/224
*	M	US-2006/0119618 A1	06-2006	Knighton et al.	345/619

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	P					
	Q					
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,745,109 A	04-1998	Nakano et al.	715/838
*	B	US-5,847,709 A	12-1998	Card et al.	715/850
*	C	US-5,930,803 A	07-1999	Becker et al.	707/104.1
*	D	US-6,313,855 B1	11-2001	Shuping et al.	715/854
*	E	US-2001/0043210 A1	11-2001	GILBERT et al.	345/420
*	F	US-6,353,452 B1	03-2002	Hamada et al.	715/825
*	G	US-6,370,537 B1	04-2002	Gilbert et al.	707/101
*	H	US-2002/0097278 A1	07-2002	Mandler et al.	345/854
*	I	US-2002/0138607 A1	09-2002	O' Rourke et al.	709/224
*	J	US-6,801,229 B1	10-2004	Tinkler, Marc	715/853
*	K	US-2005/0086612 A1	04-2005	Gettman et al.	715/848
*	L	US-2005/0168460 A1	08-2005	Razdan et al.	345/419
*	M	US-2006/0092156 A1	05-2006	Trotta et al.	345/420

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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	W	
	X	

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0113820 A1	08-2002	Robinson et al.	345/764
*	B	US-6,950,791 B1	09-2005	Bray et al.	703/22
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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